

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0263121	12-2005	Tamagawa et al.	123/179.3
*	В	US-2005/0257968	11-2005	Egami, Tsuneyuki	180/065.2
*	С	US-2005/0061563	03-2005	Syed et al.	180/065.2
*	D	US-2004/0254695	12-2004	Komiyama et al.	701/022
*	E	US-2004/0249525	12-2004	Okoshi et al.	701/022
*	F	US-2004/0099234	05-2004	Tamai et al.	123/179.3
*	G	US-2003/0088343	05-2003	Ochiai et al.	701/22
*	Н	US-2002/0179347	12-2002	Tamai et al.	180/65.2
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*	J	US-6,118,252	09-2000	Richter, Gerolf	320/132
*	К	US-6,202,615	03-2001	Pels et al.	123/179.3
*	L	US-6,247,437	06-2001	Yamaguchi et al.	123/179.3
*	М	US-6,931,318	08-2005	Kaita et al.	701/113

FOREIGN PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	В	US-6,831,429	12-2004	Fu, Zhenxing	318/139
*	С	US-6,879,888	04-2005	Ochiai et al.	701/22
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